Search Notes

Application/Control No.	Applicant(s)/Pat Reexamination	Applicant(s)/Patent under Reexamination	
10/645,058	KATAYAMA, HIDEYUKI		
Examiner	Art Unit		
Blake E. Betz	2672		

	SEAR	CHED	
Class	Subclass	Date	Examiner
345	467	12/7/2004	ВВ
	468		BB
	469	·	ВВ
455	566	12/8/2004	ВВ
400	83	12/9/2004	ВВ
	84	:	ВВ
	706		BB
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
(setting\$2 near5 character\$4 near3 number\$3) same display	12/10/2004	ВВ	
((compress\$4 or reduce\$4) near2 display) with character\$4	12/9/2004	ВВ	
(("email" or "e-mail") same display) same format and characters near3 line	12/6/2004	ВВ	